

On the futility of statistical power optimization

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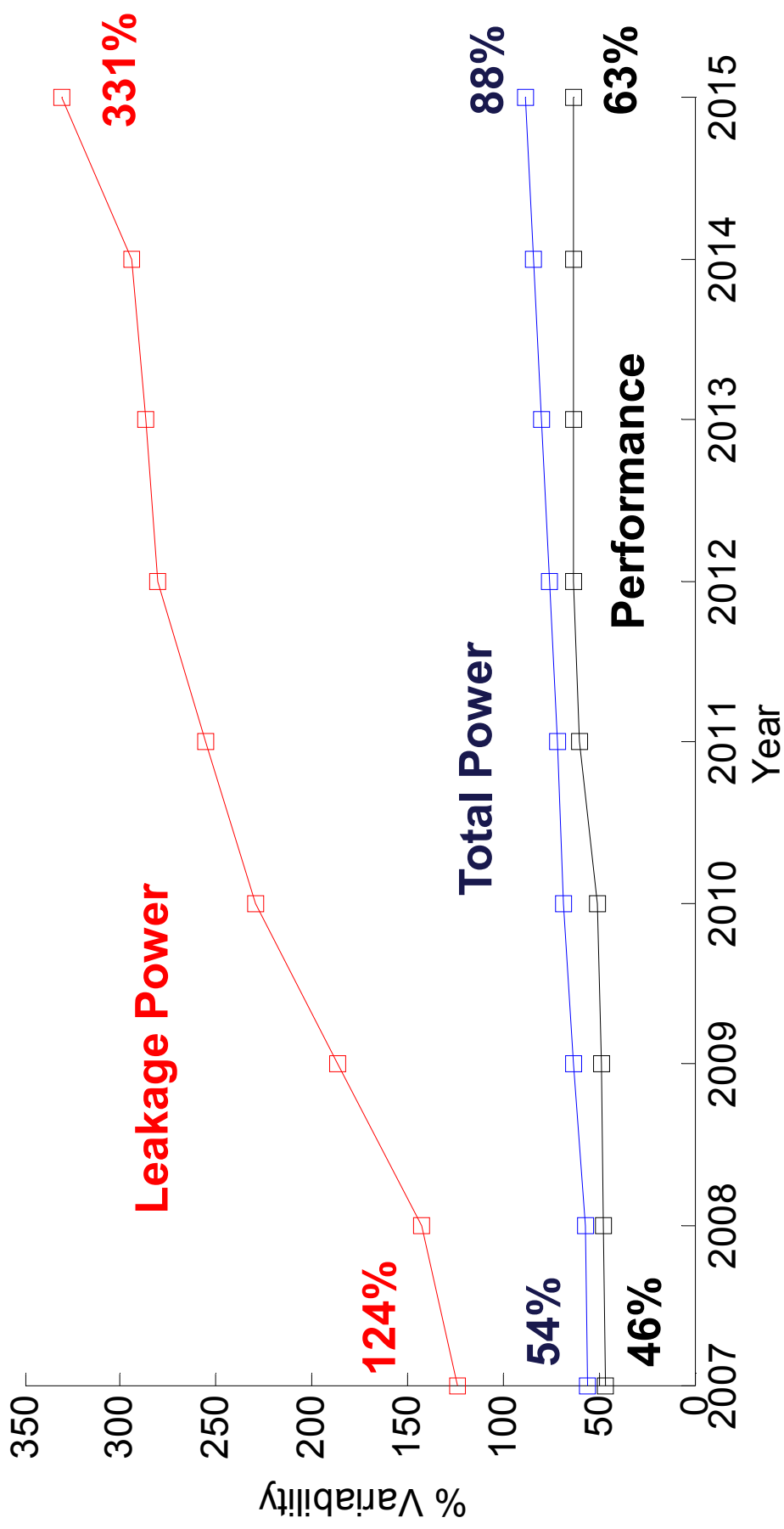
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Sponsored by SRC Contract 2006-TJ-1460,
NSF award 811832, and UC Discovery Grant ele07-10283

Power Variability



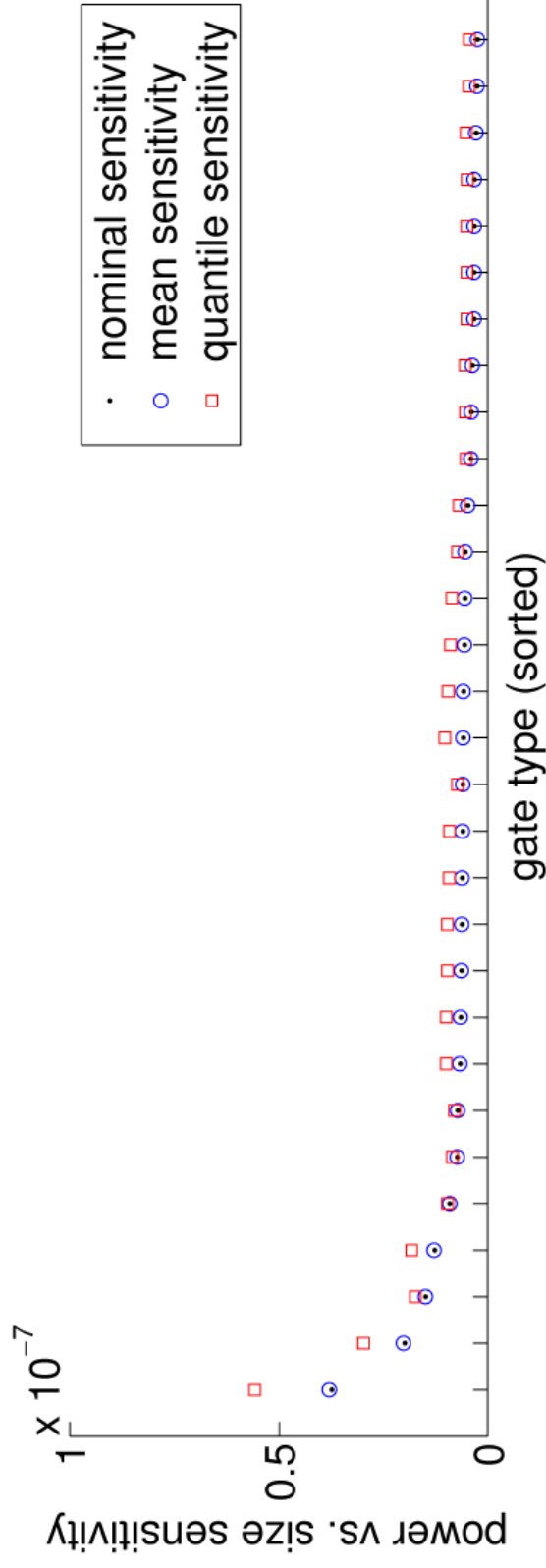
Statistical Power Optimization

- **Costs of upgrading to Statistical Power Optimization**
 - Tools
 - Programming
 - Validation
 - Modeling
 - Extract statistics (Monte-Carlo runs)
- **Limitations of Statistical Power Optimization**
 - Errors in modeling physical behavior
 - Errors in predicting input / output combinations



Statistical Power Optimization

- Power measures are similar



What is the value of Statistical Power Optimization?

Evaluating the benefits of Statistical Power Optimization

I. Sub-optimality Bounds

- “What is the maximum improvement that can be gained by optimizing statistically?”
- Results for benchmark designs in 45 nm library with gate width sizing

II. Extension to Practical Solvers: Solution Rankings

- Solvers that are non-optimal
- If a deterministic solution is in the top 10% of all deterministic sizings, will it be in the top 10% of all statistical solutions?
- Experimental validation for w , l , v_t

Statistical Power Optimization

- Works with the statistical power random variable:

$$\begin{aligned} \mathbf{P} &= \mathbf{P}_l + \mathbf{P}_d \\ &= \sum_i \kappa_i w_i e^{\alpha l_i + \beta l_i} e^{-\gamma v_{ti}} e^{\eta_i (\Delta L_{\text{dtd}} + \Delta L_{i, \text{wid}})} \quad \text{Statistical Leakage Power} \\ &\quad + \sum_i \mu_i w_i (l_i + \Delta L_{\text{dtd}} + \Delta L_{i, \text{wid}}) \quad \text{Statistical Dynamic Power} \end{aligned}$$

- Optimize w , l , v_t
 - Help manage the variability in leakage / dynamic power
 - Make designs aware of the effects of variation

Assumptions

- **Variations are in gate length only**
 - Nominal channel length: 45nm
 - Die-to-die standard deviation: 1nm
 - Within-die standard deviation: .5nm
- **Leakage power is Log-Normal**
- **Deterministic power is linear in gate sizes**
 - For l and v_t , rewrite in terms of z :
$$p = k_i (w_i e^{\alpha l_i^2 + \beta_i} e^{-\gamma v_{ti}}) = k_i z_i$$
 - Statistical power can then be written as:
$$P_{\text{statistical}} = k_i z_i e^{\eta_i (\Delta L_{\text{dtd}} + \Delta L_{i,\text{wid}})}$$
- **Commercial tools return the optimal deterministic sizing solution**

Contrast with Statistical Delay Optimization

- **Benefits of statistical delay optimization have been shown**
 - (c.f. Guthaus et. al GLSVLSI 2005)
- **Corner based methods are competitive with full statistical delay optimization**
 - (Najm DAC 2005, Burns et. al. DAC 2007)
- **Our work is separate from the statistical delay question**
 - Deterministic delay is used in this work
 - Delay model is only used for an initial deterministic solution

I. Sub-optimality bounds

Given:

- **Optimal deterministic sizing solution**
 - Synthesized to Nangate Open Cell Library (45nm standard cell library)

Find:

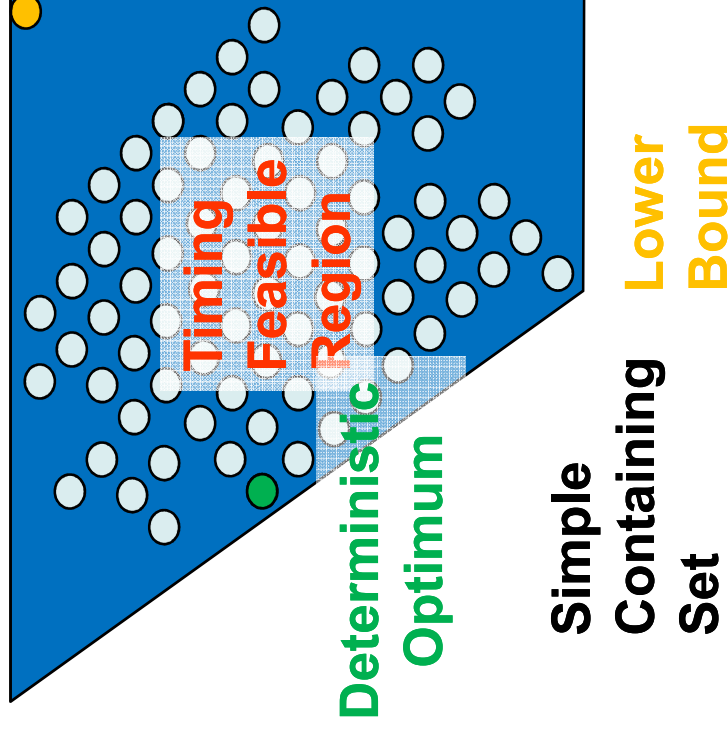
- **What is the maximum improvement that can be gained by optimizing statistically?**

Example:

- **Gate width sizing examples for benchmark circuits**

Calculating bounds: Overview

- Timing feasible region is complex - difficult to find bounds
- Use a simpler set that contains the timing feasible region
- Optimize over the simpler set to get a lower bound
- Use lower bound to find maximum improvement from Statistical Optimization



Calculating bounds: Step 1

Bounding the timing feasible region

- a. Deterministic power is linear in gate sizes, e.g. :

$$p_d(\mathbf{w}) = p(\mathbf{w}_d^*) + \nabla p(\mathbf{w}_d^*)^T (\mathbf{w} - \mathbf{w}_d^*), \quad (\mathbf{w} \in \mathbb{R}^n)$$

- b. Deterministic power optimum \mathbf{w}_d^* : smallest power sizing in the timing feasible region:

$$p_d(\mathbf{w}) \geq p_d(\mathbf{w}_d^*) \rightarrow \nabla p(\mathbf{w}_d^*)^T (\mathbf{w} - \mathbf{w}_d^*) \geq 0$$

Timing feasible region is contained in a simpler region:

$$\{\mathbf{w} \mid p_d(\mathbf{w}) \geq p_d(\mathbf{w}_d^*)\} \subseteq \{\mathbf{w} \mid 0 \leq \nabla p(\mathbf{w}_d^*)^T (\mathbf{w} - \mathbf{w}_d^*)\}$$

Calculating bounds: Step 2

Optimize over the simpler region

- Using non-linear programming to solve:

$$\begin{aligned} & \text{minimize} && p_{\text{statistical}}(\mathbf{w}) \\ & \text{subject to} && 0 \leq \nabla p(\mathbf{w}_d^*)^T (\mathbf{w} - \mathbf{w}_d^*) \\ & && \mathbf{w}_{\min} \leq \mathbf{w} \leq \mathbf{w}_{\max} \end{aligned}$$

Statistical power

Simpler region
(contains
timing feasible region)

- The solution \mathbf{w}' is a lower bound on the true statistical optimum $\mathbf{w}_{\text{statistical}}^*$
 - Timing feasible region is relaxed to a larger, continuous region

Calculating bounds: Step 3

Create bound

- \mathbf{w}' is a lower bound on the statistical optimum, $\mathbf{w}_{\text{statistical}}^*$

$$P_{\text{statistical}}(\mathbf{w}') \leq P_{\text{statistical}}(\mathbf{w}_{\text{statistical}}^*) \left(\leq P_{\text{statistical}}(\mathbf{w}_{\text{deterministic}}^*) \right)$$

suboptimality gap

- Bound the suboptimality gap using the percentage:

$$\delta_{\text{so}} = \frac{P_{\text{statistical}}(\mathbf{w}_{\text{deterministic}}^*) - P_{\text{statistical}}(\mathbf{w}')}{P_{\text{statistical}}(\mathbf{w}_{\text{deterministic}}^*)}$$

Bounds for Benchmarks: Example

Worst Case Sub-optimality:

Mean Power δ_{so} : **.24%** (= 13.24-13.21) / 13.24

Mean + 3 Sigma δ_{so} : **2.5%** (= 17.35-16.91) / 17.35

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Optimized
Sizes for
Deterministic
Power

Deterministic Power: 13.08 μ W
Mean Power: 13.24 μ W
Mean + 3 Sigma Power: 17.35 μ W

Lower Bound
Calculation

Mean Power Lower Bound:

13.21 μ W

Mean+3 Sigma Power Lower Bound:

16.91 μ W

Sub-optimality results: Leakage power optimization

ISCAS '85 benchmarks and ALU circuit

Synthesized speeds

	Mean Power				Sigma Power				
	v1	v2	v3	v4	v1	v2	v3	v4	avg
c432	fastest	0.3%	0.4%	slowest	fastest	5.3%	7.7%	slowest	6.0%
c499		0.2%	0.1%			1.7%	1.0%		1.5%
c880	0.2%	0.2%	0.2%	0.2%	1.7%	2.5%	3.0%	2.6%	2.5%
c1355					2.1%	1.7%	1.2%	1.2%	1.5%
c1908					2.0%	3.9%	4.1%	4.3%	3.6%
c2670	0.2%	0.2%	0.2%	0.2%	2.8%	2.1%	2.0%	2.0%	2.2%
c3540	0.2%	0.2%	0.2%	0.2%	1.2%	1.7%	2.6%	2.6%	2.0%
c5315	0.2%	0.2%	0.2%	0.2%	2.7%	2.7%	2.5%	2.5%	2.6%
c6288	0.2%	0.2%	0.2%	0.2%	2.0%	1.5%	1.8%	1.1%	1.6%
c7552	0.2%	0.2%	0.2%	0.2%	2.2%	1.2%	1.7%	1.1%	1.5%
alu					1.9%	2.7%	2.5%	1.2%	2.1%

Open Cores ALU

(Upper bounds on the improvement from using Statistical Power Optimization)

Sub-optimality results: Total power optimization

ISCAS '85 benchmarks and ALU circuit

	Mean Power			Mean + 3 Sigma Power		
	<i>minimum</i>	<i>maximum</i>	<i>average</i>	<i>minimum</i>	<i>maximum</i>	<i>average</i>
switching probability						
1%	~0%	0.003%	~0%	~0%	0.036%	0.006%
0.10%	0.001%	0.004%	0.002%	0.005%	0.055%	0.021%

- **The impact of statistical power variations is diminished by the dynamic power**

- Dynamic power is larger than leakage power
- Deterministic and statistical dynamic power are highly linearly correlated
- Variations in dynamic power are smaller

II. Solution Rankings

Question

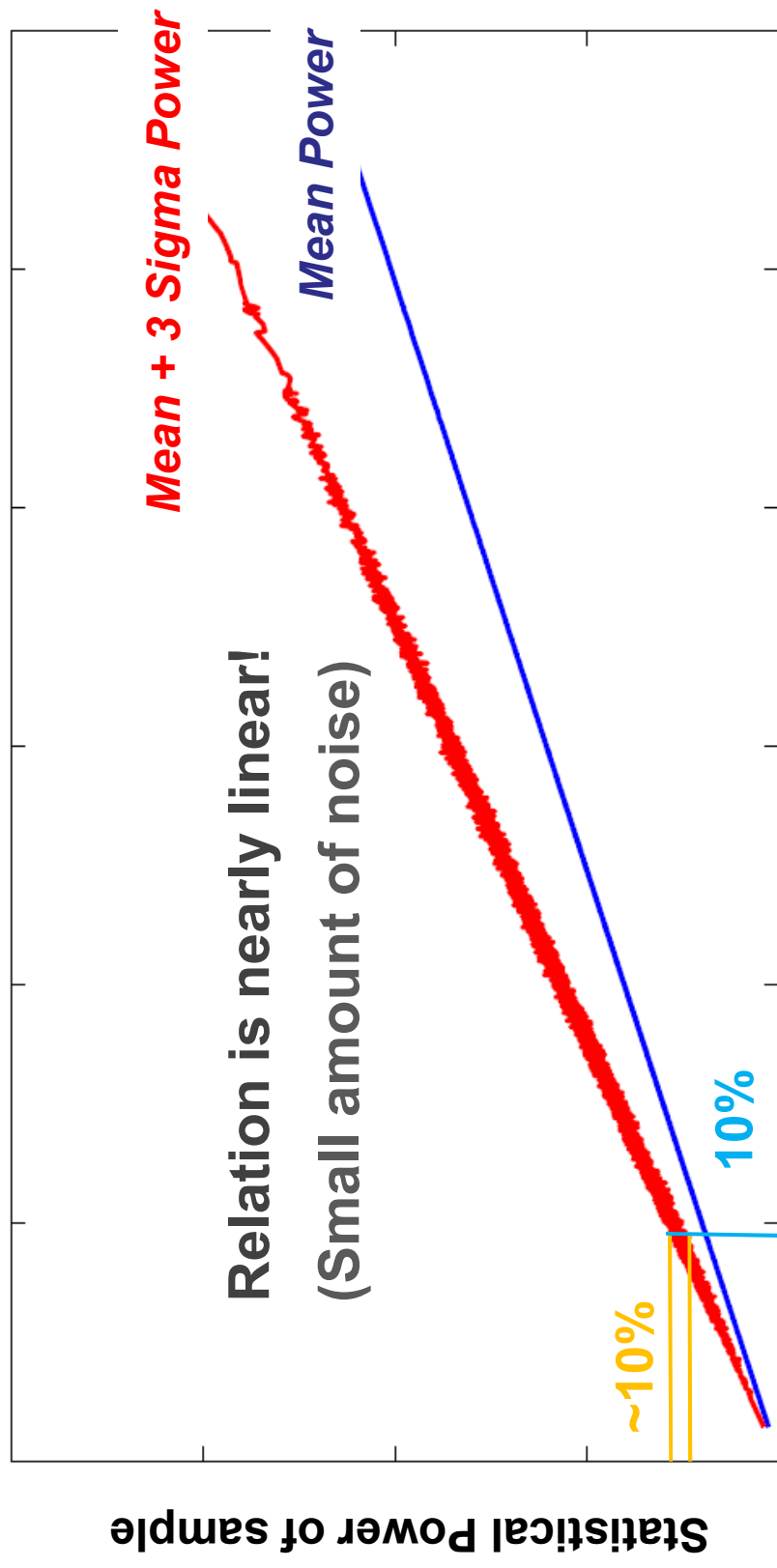
- Suppose the deterministic solution is within the top 5% of all deterministic sizings
- Will this also be in the top 5% of all statistical solutions?

Experimental validation

- Generated random w , l , vt assignments
- For each assignment:
 - Compared the deterministic power with the statistical power

Solution Rankings

Deterministic Power vs. Statistical Power
(random size assignments)



Deterministic Power of sample

Benchmark c432

Quantifying the correlation

- The deterministic and statistical powers are nearly linear relations:

$$P_{\text{statistical}}(w, l_{\text{eff}}, V_t) = \left(\alpha P_{\text{deterministic}}(w, l_{\text{eff}}, V_t) + \beta \right) + \text{error}(w, l_{\text{eff}}, V_t)$$

- Error statistics:

		Leakage Power			Mean + 3 Sigma Power		
variables	Mean Power	min	max	avg	min	max	avg
w	.004%	.03%	.08%	.01%	.07%	.65%	.19%
w, vt	.009%	.08%	.14%	.02%	.15%	1.8%	.46%
w, vt, l	.016%	.14%		.04%	.36%	3.5%	.86%
Total Power (switching frequency = .001)							
w, vt, l	.005%	.10%		.024%	.077%	3.3%	.98%

Summary

- **Presented framework to:**
 - Bound the maximum improvement that can be gained by optimizing statistically
 - Experimentally compare the statistical quality of a deterministic sizing
- **Statistical power optimization gives modest gains**
 - Leakage power: on average 2-3% improvement at best
 - Total power: < 1% improvement at best
- **Quality deterministic power solutions are quality statistical power solutions**
 - The values correlate nearly linearly with small error
 - Expect the sub-optimality to be small

Future Goals

- **Model V_t variations**
- **Statistical delay measures**
- **Generalized distributions**